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# Polymeric Electron-Selective Contact for Crystalline Silicon Solar Cells with an Efficiency Exceeding 19%

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**Cite This:** ACS Energy Lett. 2020, 5, 897–902

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ABSTRACT: Carrier-selective contacts have become a prominent path forward toward efficient crystalline silicon (c-Si) photovoltaics. Among the proposed contacting materials, organic materials may offer simplified and low-cost processing compared with typical vacuum deposition techniques. Here, branched polyethylenimine (b-PEI) is presented as an electrontransport layer (ETL) for c-Si solar cells. The incorporation of a b-PEI interlayer between c-Si(n) and Al leads to a low contact resistivity of 24 m $\Omega$ cm<sup>2</sup>. A silicon heterojunction solar cell integrated with b-PEI is demonstrated achieving a power conversion efficiency of 19.4%, which improves the benchmark efficiency of a c-Si solar cell with an organic ETL. This electron selectivity of b-PEI is attributed to its Lewis basicity, i.e., electron-donating ability, promoting favorable band bending at the c-Si surface for electron transport. Moreover, several other Lewis base polymers perform as efficient ETLs in organic/c-Si hybrid devices, indicating Lewis basicity could be a guideline for future organic ETL design.



**SUPPORTING Information** 

esearch on carrier-selective contacts for crystalline silicon (c-Si) photovoltaics (PV) has achieved great progress in recent years, with an expanded library of available electron and hole transport layers (ETLs and HTLs), offering opportunities for improved understanding of device physics as well as enabling efficient solar cells with low-cost, scalable materials and processes.<sup>1</sup> Different classes of materials, such as oxides, halides, nitrides, and organic molecules, have been demonstrated as ETLs and HTLs on pristine and/or passivated c-Si surfaces.<sup>2-9</sup> Compared with conventional PV technologies, the implementation of full-area carrier-selective contacts eliminates the high-temperature diffusion and contact patterning steps, resulting in a simplified fabrication processes. In addition, many carrier-selective contact materials have the potential to mitigate or eliminate the fundamental physical loss mechanisms that constrain the power conversion efficiency (PCE) of c-Si solar cells fabricated with conventional contacting schemes (e.g., parasitic free carrier absorption, Auger recombination, and band narrowing).<sup>10-12</sup> Organic molecules offer a wide variety of candidate materials for selective contacts because of their adjustable functional group modification and offer great promise for low-cost fabrication. Among the organic materials, poly(3,4-ethylene dioxythiophene):poly(styrenesulfonate) (PEDOT:PSS) has received increasing interest in hybrid organic/c-Si solar cells

because of its relatively high work function (5.0-5.1 eV), passivation effect on c-Si surfaces, and transparent conductive properties.<sup>8,14-16</sup> By using PEDOT:PSS as front- and rear-side HTL, c-Si solar cells have been reported with the promising PCEs of above 16% and 20%, respectively.<sup>8,17</sup>

As for the electron-selective contact, a simple, directly metallized c-Si(n)/Al contact is well-known to exhibit a large energy barrier for electrons as well as severe carrier recombination because of the high concentration of surface defects, including metal induced gap states.<sup>18–20</sup> Therefore, an efficient electron-selective contact is also required in the design of hybrid organic/c-Si solar cells. Several types of organic molecules have been demonstrated as ETLs for c-Si cells, such as PEO (poly(ethylene oxide)), Liq (8-hydroxyquinolinolato lithium), CPTA (C<sub>60</sub> pyrrolidine tris-acid), and amino acids, among which L-histidine, an amino acid, is used as an electron-selective contact of c-Si(n) cells with a PCE of 17.9%.<sup>21–25</sup> Common to all of these devices is a relatively low open-circuit voltage ( $V_{oc}$ ), due to poor surface passivation, which hinders

Received: January 16, 2020 Accepted: February 19, 2020 Published: February 19, 2020





Figure 1. (a) I-V characteristic of the b-PEI/Al stack on 1  $\Omega$  cm c-Si(*n*). The thickness of the b-PEI layer ranges from 0 to 10 nm, and the inset is the cross section of structure for measurement. (b) Extracted contact resistivity ( $\rho_c$ ) of 2 nm b-PEI/Al heterocontact on *n*-type 1  $\Omega$  cm silicon wafers. The inset shows the TLM structure for  $\rho_c$  extraction. (c) Effective carrier lifetime ( $\tau_{eff}$ ) vs excess carrier density of a-Si:H(*i*) passivated c-Si(*n*) before and after b-PEI coating. The molecular structure of b-PEI is shown.



Figure 2. (a) Tauc plot for b-PEI layer showing an optical bandgap  $(E_g)$  of ~6.15 eV. The inset shows the transmittance measurement ranging from 180 to 1400 nm. (b) Low work function (WF) of b-PEI/Al stack yielded by the secondary electron cutoff. (c) Schematic of energy band diagram for b-PEI/Al as heterocontact implementing a-Si:H(i) as interlayer. The right panel shows a zoomed-in view of positive charges in the b-PEI layer.

the PCE of hybrid organic/c-Si solar cells with organic ETLs. The search for an organic ETL that is compatible with a well-passivated c-Si architecture (e.g.,  $SiO_2/c$ -Si, a-Si:H/c-Si) has been elusive to date, motivating the present work.

Polyethylenimine (PEI) is a polymer containing a high concentration of amine groups. Lone pairs of electrons from nitrogen atoms in PEI contribute to its relatively strong Lewis basicity, i.e., its electron-donating capability. Previously, PEI was reported as an effective ETL for organic and perovskite solar cells and organic light-emitting diodes, as well as an *n*-type dopant in electronic devices.<sup>26-31</sup> Despite this wide range of applications, the study of PEI on c-Si solar cells as electron contact has not been reported yet. Herein, we demonstrate that branched PEI (b-PEI) leads to a low contact resistivity in c-Si(n)/b-PEI/Al electron-selective contact stacks. By implementation of b-PEI as ETL in silicon heterojunction solar cells, a champion PCE of 19.4% is achieved. This PCE is the first to be reported for a hybrid organic/c-Si device exceeding 19% using an organic ETL. Our further study of several other Lewis base polymers indicates a relationship between Lewis base strengths and ETL characteristics, which could be a guideline for the future contact design of hybrid organic/c-Si solar cells.

The b-PEI ethanol solution was spin-coated on a polished 1  $\Omega$  cm c-Si(*n*) wafer, yielding b-PEI layers with thickness of 2–

10 nm. Spin-coating was performed under identical conditions for all samples, where the film thickness was controlled by using different solution concentrations ranging from 0.01 to 0.10 wt % (details are presented in Methods). The morphology of b-PEI was characterized by atomic force microscopy (AFM), shown in Figure S1. We found that the thin layer is continuous, featuring a surface roughness  $R_a$  of 0.19 nm, which is much smaller than its thickness (>2 nm). Aluminum (Al) was thermally evaporated in the subsequent step as the electrode for I-V measurements. The I-V characteristics versus b-PEI thickness relationship was studied, featuring a contact structure in Figure 1a. Compared with the c-Si(n)/Alcontact, resistance significantly decreases after incorporating a 2 nm thick b-PEI interlayer between c-Si(n) and Al. The contact becomes resistive when the b-PEI thickness is ~6 and 10 nm, indicating an electron-tunneling mechanism through b-PEI. The contact resistivity  $\rho_c$ , determined by the transfer length method (TLM), is extracted as 24 m $\Omega$  cm<sup>2</sup> from the 2 nm b-PEI/Al stack in Figure 1b. With the addition of a plasmaenhanced chemical vapor deposition (PECVD)-deposited intrinsic hydrogenated amorphous silicon a-Si:H(i) passivating interlayer, the c-Si(n)/a-Si:H(i)/b-PEI/Al heterocontact is found to remain Ohmic, with  $\rho_c = 156 \text{ m}\Omega \text{ cm}^2$  (see Figure S2). Such a-Si:H(i) passivating interlayer is typically employed

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Figure 3. (a) Architecture of an *n*-type silicon heterojunction cell integrating with a b-PEI layer. (b) J-V characteristics of the *n*-type heterojunction cell with different thickness of b-PEI layers collected under standard 1 sun conditions. The labeled film thickness refers to the previous thickness on a planar wafer because of the difficulty of measuring polymer thickness on a textured surface. (c) Wavelength-dependent external QE, reflection, and internal QE for the champion device. The integrated  $J_{sc}$  (after contact fraction correction) is calculated, and the photograph of the cell front design is shown in the inset.

in silicon heterojunction solar cells, inserted between wafer and ETL or HTL, resulting in very high operating voltages for such devices.<sup>32</sup> The a-Si:H(*i*) films we used here were optimized for such purposes. We investigated the effect of b-PEI layer on a-Si:H(*i*) passivation quality by effective carrier lifetime measurement, which is shown in Figure 1c. The red circles and black squares represent the injection-level-dependent effective carrier lifetime of a 3  $\Omega$  cm c-Si(*n*) wafer with double-side a-Si:H(*i*) passivation before and after 3 nm thick b-PEI capping, respectively. The results show the effective carrier lifetime (at the injection level of  $10^{15}$  cm<sup>-3</sup>, corresponding to typical solar cell operating conditions under 1 sun illumination) remains constant before and after b-PEI coating, featuring a high value of 2.4 ms and an implied  $V_{\rm oc}$  of 725 mV.

Materials-based characterizations of b-PEI were then performed. An 80 nm thick b-PEI layer was spin-coated on a fused SiO<sub>2</sub> substrate for optical transmittance and absorption measurements. Its Tauc plot is provided in Figure 2a with the extracted bandgap of 6.15 eV; its large value is in line with the result of resistance versus thickness in Figure 1a. The inset of Figure 2a plots the transmittance of b-PEI from 180 to 1400 nm, which includes the absorption spectra of c-Si solar cells. Its transmittance is close to 100% in most of the measured range and starts to decrease when the wavelength is shorter than 300 nm, showing that b-PEI possesses higher transparency than conventional a-Si:H(n) contact. The high-resolution X-ray photoelectron spectroscopy (XPS) spectra of N 1s from different thickness of b-PEI layers on c-Si(n) substrate was collected (Figure S3). The predominant peak of 399.1 eV is from the amine groups of b-PEI when the film thickness is  $\sim$ 80 nm.<sup>33</sup> A peak of 400.3 eV appears when we collected the signal from 3 and 12 nm thick b-PEI layers, assigned to positively charged N atoms in b-PEI.<sup>34</sup> This peak can be mainly interpreted as the charge transfer at the b-PEI/c-Si(n) interface which leads to a positively charged b-PEI layer. The work function of b-PEI/Al contact was obtained from the secondary electron cutoff. Figure 2b shows this contact has a low work function of 2.93 eV, which is the reason for Ohmic contact and low resistivity on pristine and a-Si:H(i) passivated c-Si(n), as demonstrated for other inorganic low work function ETLs.<sup>5,35</sup> The energy band diagram is shown schematically in Figure 2c. As a Lewis base, b-PEI has strong tendency to donate

electrons, resulting in a positively charged layer, corresponding to the measured low work function. We estimate the upper limit of positive charge density in b-PEI interlayer equal to  $5 \times 10^{12}$  cm<sup>-2</sup> as a simple guideline by utilizing assumptions discussed in previous research.<sup>36</sup> Because of the charge neutrality principle, electrons in c-Si accumulate at the interface. The energy band of c-Si bends downward at this interface, and electrons can be transported from c-Si to Al with a low barrier height.

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The b-PEI/Al contact is finally integrated into a  $2 \times 2 \text{ cm}^2$ silicon heterojunction cell, the architecture of which is sketched in Figure 3a. This device features a random pyramid textured front surface, capped with a stack of i/p a-Si:H as passivating hole-selective contact at the front side. Onto this HTL, an indium tin oxide (ITO) layer was sputtered and grid metallization was applied. The b-PEI layer was then spincoated on the textured and a-Si:H(i)-passivated rear side with different thickness, followed by thermal evaporation of Al as full-area rear electrode. The I-V curves measured under 1 sun illumination are shown in Figure 3b. The champion PCE reaches 19.4% in the optimal 3 nm b-PEI cell, which is the new benchmark for hybrid organic/c-Si solar cells using an organic ETL. This device is characterized by  $V_{oct} J_{sct}$  and fill factor (FF) values of 720 mV, 37.0 mA cm<sup>-2</sup>, and 72.9%, respectively. The series resistances of cells with 2 and 3 nm thick b-PEI are extracted as 2 and 2.9  $\Omega$  cm<sup>2</sup>, respectively, which could be further decreased by modifying b-PEI with functional groups to increase its electron conductivity. The J-V curves of the fabricated cells exhibit an "S-shape" when the coated b-PEI layer is thicker than 3 nm, consistent with the increasing contact resistance of b-PEI/Al stack in Figure 1a. As the b-PEI layer becomes thicker, this parasitic resistance from the contact also undermines the  $V_{\rm oc}$  of cells. Figure 3c shows the measured external quantum efficiency (EQE), reflection, and internal quantum efficiency (IQE) of the champion device. All these measurements were taken between the Ag metal grid fingers. The inset is a photograph of the fabricated cell with a contact fraction of  $\sim$ 5%. The integration of the EQE weight against the AM 1.5 solar spectrum product gives  $J_{sc} = 38.8 \text{ mA cm}^{-2}$ without contact fraction correction and 36.9 mA  $cm^{-2}$  after correction, which is in line with the  $J_{sc}$  derived from J-Vmeasurements. The relatively low EQE in the short wavelength region is attributed to the relatively strong parasitic absorption of the i/p a-Si:H stack.<sup>10</sup> This implies that a higher  $J_{sc}$  and PCE can be achieved by utilizing hole-selective contacts with a better optical transparency.

The effect of Lewis basicity on c-Si solar cell performance was also further studied. Several commercial Lewis base polymers were tested on silicon heterojunction cells, the molecular structures of which are shown in Figure 4a. The



Figure 4. (a) Molecular structures of tested commercial Lewis base polymers. (b) J-V characteristics of *n*-type heterojunction cell with different Lewis base polymers as organic ETLs. Al (gray curve) is fabricated without any polymer interlayer for comparison.

Lewis basicity of linear PEI (1-PEI), polyethylenimine ethoxylated (PEIE), and poly(4-vinylpyridine) (P4VP) mainly originate from the paired electrons of nitrogen in amine groups and pyridine N. Polyethylene glycol (PEG) and poly(vinyl alcohol) (PVA) show basicity due to the paired electrons of oxygen in ether and hydroxyl group. All of these polymers were dissolved in ethanol with a concentration of 0.02 wt % and spin-coated via the same recipe used to fabricate the cells with a b-PEI layer. The illuminated J-V curves are plotted in Figure 4b. The cells implemented with l-PEI, PEIE, and P4VP layers achieve PCEs ranging from 17.9% to 19.4%, the  $V_{\rm oc}$  of which are all >690 mV, demonstrating effective electron collection by these Lewis base polymers. The cells coated by PVA and PEG are less effective and exhibit lower PCEs of approximate 15% with a  $V_{\rm oc}$  of ~590 mV. The  $J_{\rm sc}$  difference results from the different optical properties and thickness of the polymers. For comparison, the light gray curve refers to thermally evaporated Al electrode without a polymer interlayer, featuring a very low  $V_{\rm oc}$  (<300 mV) due to metal-induced recombination as well as a poor electron selectivity. Noticeably, it is well-known that amine and pyridine are stronger than ether and hydroxyl in terms of basicity.<sup>37</sup> PEG and PVA as weaker Lewis bases will not induce enough downward band bending of c-Si for efficient electron collection. Therefore, devices with PEG and PVA show lower  $V_{\rm oc}$ . These results indicate that the Lewis base strengths of organic ETLs can be an important factor related to the performance of electron-selective contacts in c-Si solar cells.

In this study, we have demonstrated b-PEI as an effective organic ETL that can be integrated into an a-Si:H(*i*) passivating electron-selective contact for c-Si solar cells. The highly transparent spin-coated b-PEI enables low contact resistivity with Al on c-Si(*n*). The device with an electron-selective contact composed of a-Si:H(*i*)/b-PEI/Al shows a PCE up to 19.4%, which improves the benchmark PCE demonstrated in a hybrid organic/c-Si solar cell with an

organic ETL. The  $V_{\rm oc}$  is >700 mV, indicating a low surface recombination velocity and efficient electron collection. The electron-selectivity of the b-PEI contact is attributed to the relatively strong Lewis basicity of b-PEI, resulting in a positively charged b-PEI layer and favorable downward band bending of c-Si, in line with a measured low work function of 2.93 eV. Importantly, several other polymers with different Lewis basicity also show a similar performance on c-Si solar cells, indicating a generality of this concept. Future study on associating the Lewis base strengths versus device performance may yield a universal guideline for organic electron contact design in c-Si solar cells and may even be expanded to inorganic contacts.

## METHODS

Chemicals and Solution Preparation. Branched polyethylenimine solution (b-PEI) (50 wt % in H<sub>2</sub>O, average  $M_{\rm w} \approx 750\,000$  by LS), linear polyethylenimine (l-PEI) (average  $M_{\rm n} \leq 000$ ), polyethylenimine 80% ethoxylated solution (PEIE) (37 wt % in H<sub>2</sub>O), poly(4-vinylpyridine) (P4VP) (average  $M_{\rm w} \approx 60\,000$ ), poly(ethylene glycol) (PEG) (average  $M_{\rm n} 20\,000$ ) and poly(vinyl alcohol) (PVA) ( $M_{\rm w}$  13 000–23 000, 87–89% hydrolyzed) were purchased from Sigma-Aldrich. Branched polyethylenimine was diluted to 0.01–0.10 wt % solutions by ethanol.

Contact and Materials Characterization. Contact resistivity samples were fabricated on the 1  $\Omega$  cm *n*-type (100) c-Si wafer. After a diluted hydrofluoric acid (HF) dip for native oxide removal, the wafer was spin-coated by b-PEI with the recipe of 4000 rpm for 60 s. The thickness of b-PEI layer was controlled by using different concentration of solutions, measured by ellipsometer (J. A. Woollam M-2000, analyzed by Cauchy model). The solution concentration of 0.01, 0.02, 0.05, and 0.10 wt % corresponds to the b-PEI layer thickness of  $\sim$ 2, 3, 6, and 10 nm, respectively. All the above steps were processed under ambient conditions. Subsequently, Al (~150 nm) was deposited by thermal evaporation through a shadow mask in order to obtain a transfer-length-method (TLM) pattern. I-Vcharacteristics with different pad spacing were done by a Keithley 2400 SourceMeter and a Agilent 4155C. Contact resistivity on passivated 1  $\Omega$  cm c-Si(n) was extracted by using the same method. The parallel resistance through the b-PEI layer was assumed to be negligible because it was thin and insulating. Lifetime samples were prepared on 3  $\Omega$  cm *n*-type c-Si wafers with random-pyramid textured. After standard Radio Corporation of America (RCA) cleaning and dipping in a dilute HF solution, a-Si:H(i) layers were deposited in an INDEOtec Octopus II PECVD cluster tool at 200 °C. The b-PEI layer was spin-coated on this passivated wafer by using 0.02 wt % solution and the same recipe as before. Effective carrier lifetime was measured by a Sinton WCT 120 photoconductance tester in transient mode. Optical measurements were made by an Agilent Cary 5000 UV-vis-NIR spectrometer. AFM for the surface morphology of b-PEI layer was conducted by a Dimension ICON AFM instrument (Bruker, Germany) under ambient conditions. The XPS results were collected by a Kratos AXIS Ultra DLD system with a monochromatic Al K $\alpha$  X-ray source and a hemispherical analyzer. Thin films of b-PEI were spin-coated on polished c-Si(n) wafer for XPS characterization. The XPS data were plotted with the C 1s correction. Work function was extracted from the secondary electron cutoff by UPS mode and an added

bias in this XPS system. Sample for work function was prepared as b-PEI/Al stack on c-Si(n) wafer, within which Al was patterned by shadow mask. The measurement was conducted at the edge of the Al pad to observe the work function of the stack.

Cell Fabrication and Characterization. The  $2 \times 2$  cm<sup>2</sup> n-type cells were fabricated on high-quality float-zone c-Si(n)substrates (1  $\Omega$  cm, ~250  $\mu$ m). After random pyramid texturing in an alkaline solution and a standard RCA cleaning, a stack of intrinsic and boron-doped a-Si:H (i/p a-Si:H) was deposited on the front side of the wafer utilizing hydrogen, silane, and trimethyl boron as the input gases. An a-Si:H(i)passivation layer was deposited on the rear side after flipping. All the a-Si:H layers were deposited in an INDEOtec Octopus II PECVD cluster tool at 200 °C. Then the front transparent conductive window layer, ITO (75 nm), was capped by sputtering through a shadow mask, defining the active cell area. The front metallization was prepared by screen-printing using a low-temperature Ag paste and curing at 200 °C for 15 min in air. The rear side was treated by diluted HF and then was capped by b-PEI via spin-coating at 4000 rpm for 60 s. Then Al (~150 nm) was thermally evaporated on the top of b-PEI layer. The cells integrated with l-PEI, PEIE, P4VP, PEG, and PVA were fabricated by the same spin-coating recipe and processing steps. The 1 sun J-V measurement was performed by a solar simulator under standard conditions (100 mW  $cm^{-2}$ , 25 °C, AM 1.5G spectrum) and an aperture mask to avoid peripheral absorption. The quantum efficiency analysis was made by an Enlitech QE-R solar cell quantum efficiency measurement system. The EQE, reflection, and IQE were measured between Ag grid fingers.

### ASSOCIATED CONTENT

#### Supporting Information

The Supporting Information is available free of charge at https://pubs.acs.org/doi/10.1021/acsenergylett.0c00110.

AFM morphology characterization of b-PEI layer, extracted contact resistivity ( $\rho_c$ ) of b-PEI/Al heterocontact on a-Si:H(*i*)/c-Si(*n*), and high-resolution XPS spectra of N 1s from b-PEI layers (PDF)

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#### Notes

The authors declare no competing financial interest.

## ACKNOWLEDGMENTS

The authors thank Zhen Yuan for help with electrical measurements. Materials characterization was supported by the Electronic Materials Programs, funded by the Director, Office of Science, Office of Basic Energy Sciences, Material Sciences and Engineering Division of the U.S. Department of Energy under Contract No. DE-AC02-05CH11231. XPS characterization was performed at the Joint Center for Artificial Photosynthesis, supported through the Office of Science of the U.S. Department of Energy under Award No. DE-SC0004993. Work at the Molecular Foundry was supported by the Office of Science, Office of Basic Energy Sciences, of the U.S. Department of Energy under Contract No. DE-AC02-05CH11231. Device fabrication was funded by King Abdullah University of Science & Technology under Contract No. OSR-2017-GRGG-3383.01.

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